

Search Notes

Application/Control No.

10/655,962

Examiner

Kim Huynh

Applicant(s)/Patent under
Reexamination

LIU KAN, HAN-MEI

Art Unit

2182

SEARCHED

Class	Subclass	Date	Examiner
710	62, 63, 305	4/22/05	g
361	686	L	L
713	340	L	L

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST, USPTO, PGPUB, OCR, DERWENT, JPO, EPO, NPL, PLUS searched and checked	4/22/05	g